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(12) **United States Design Patent**  
**Chang**

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(45) **Date of Patent:** **\*\* Apr. 8, 2003**

(54) **CLAMP TYPE ELECTRICAL MULTIMETER (I)**

D447,070 S \* 8/2001 Chen ..... D10/79  
D450,002 S \* 11/2001 Chang ..... D10/79

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\* cited by examiner

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(\*\*) Term: **14 Years**

(57) **CLAIM**

(21) Appl. No.: **29/160,230**

The ornamental design for a clamp type electrical multimeter (I), as shown and described.

(22) Filed: **May 8, 2002**

**DESCRIPTION**

(51) **LOC (7) Cl.** ..... **10-04**

(52) **U.S. Cl.** ..... **D10/79**

(58) **Field of Search** ..... D10/79; 324/115-117,  
324/126-130, 142, 143, 149, 156, 158 P,  
158 F

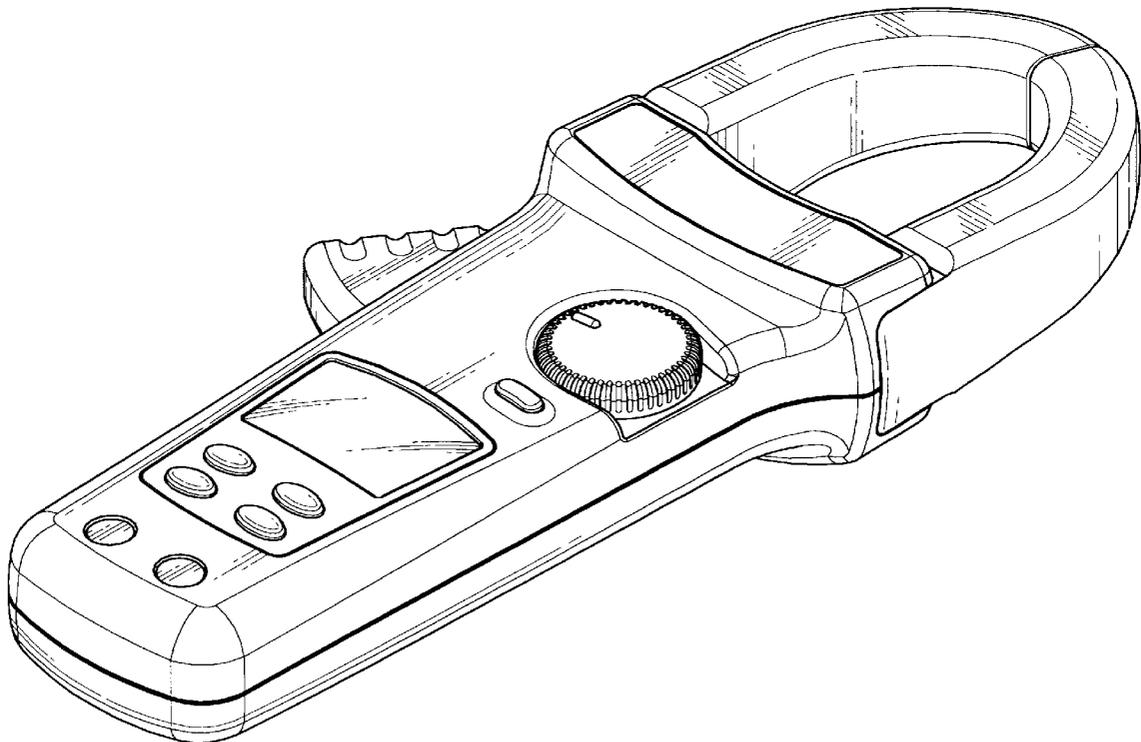
FIG. 1 is a perspective view of the clamp type electrical multimeter (I) showing the new design;  
FIG. 2 is a front view of the new design;  
FIG. 3 is a rear view of the new design;  
FIG. 4 is a left view of the new design;  
FIG. 5 is a right view of the new design;  
FIG. 6 is a top view of the new design; and,  
FIG. 7 is a bottom view of the new design.

(56) **References Cited**

**U.S. PATENT DOCUMENTS**

D440,892 S \* 4/2001 Kuramoto ..... D10/79

**1 Claim, 6 Drawing Sheets**



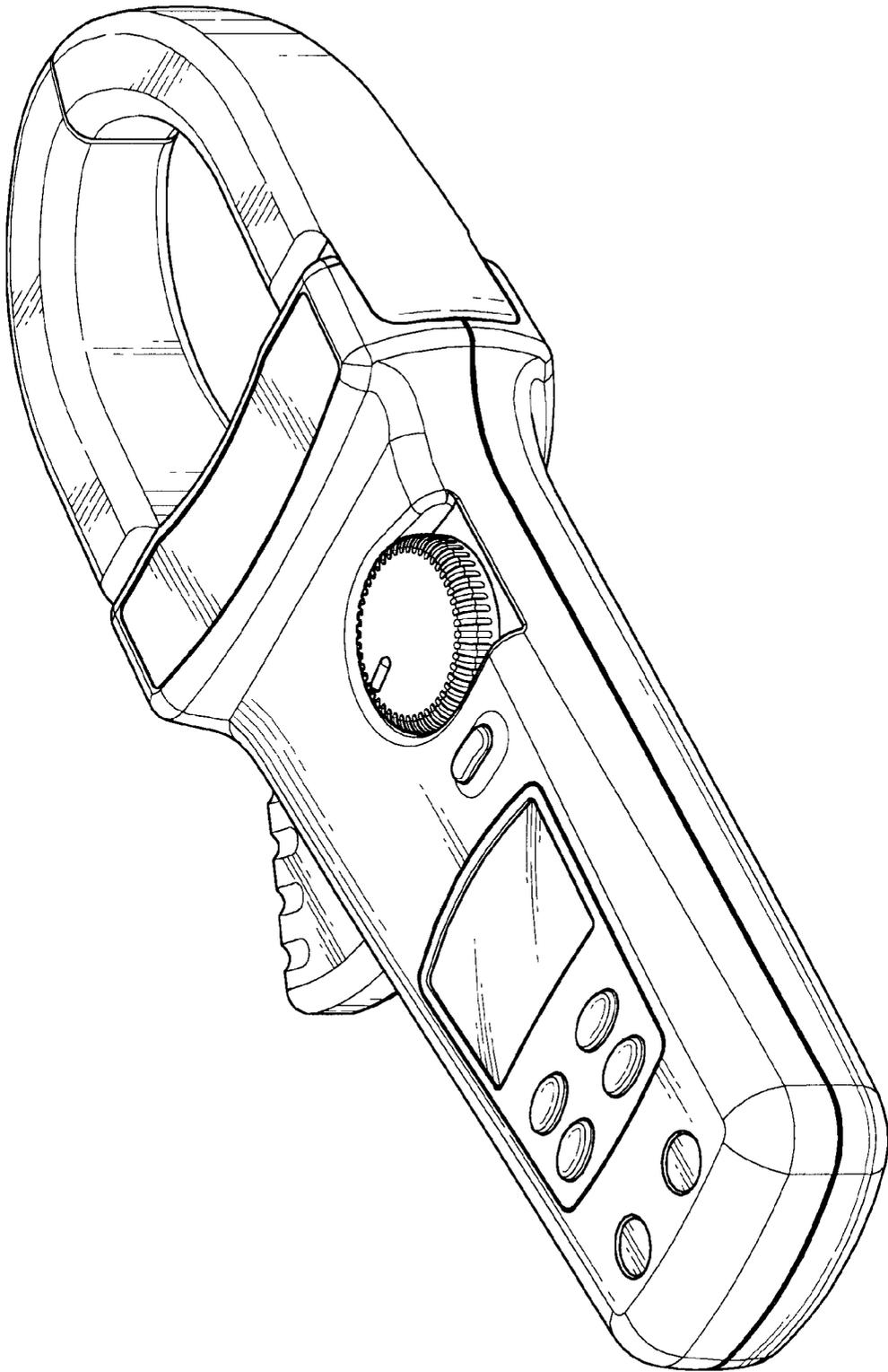


Fig. 1

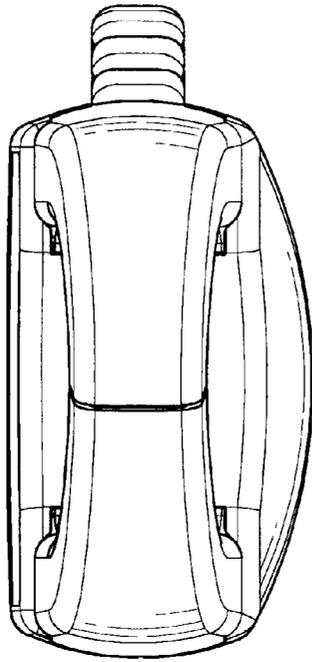


Fig. 3

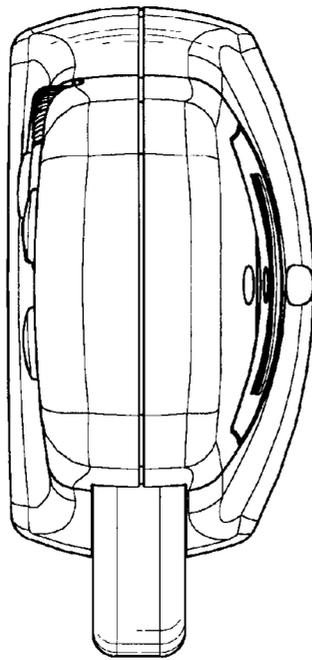


Fig. 2

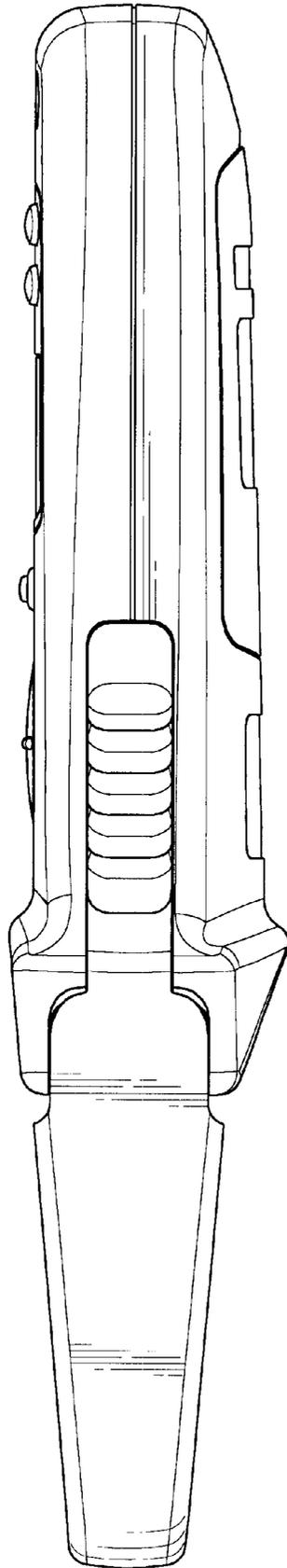


Fig. 4

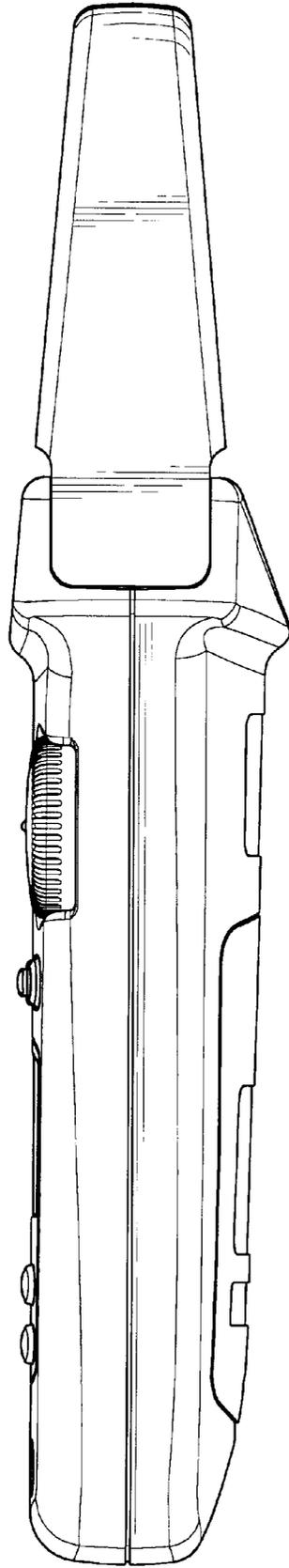


Fig. 5

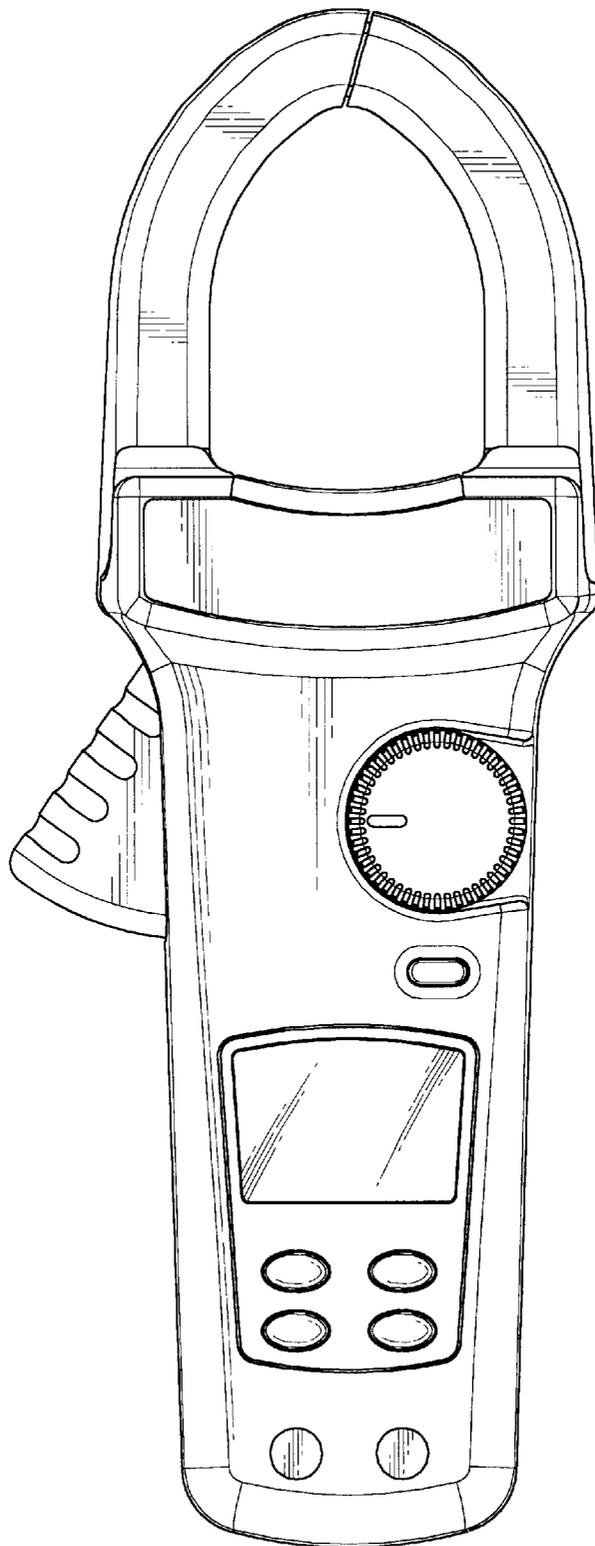


Fig. 6

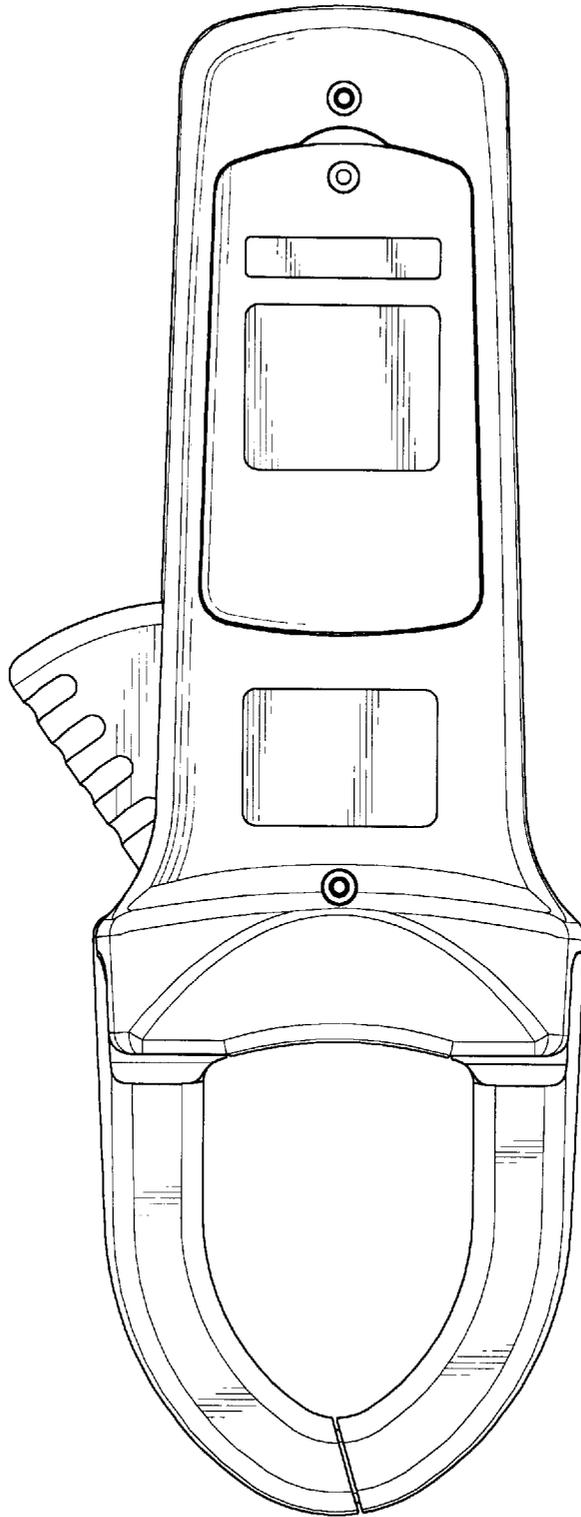


Fig. 7